

Notice of References Cited	Application/Control No. 10/760,012	Applicant(s)/Patent Under Reexamination SUGAHARA ET AL.	
	Examiner Max Shikhman	Art Unit 2609	Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,915,027 A	06-1999	Cox et al.	380/54
*	B	US-5,991,426 A	11-1999	Cox et al.	382/100
*	C	US-6,055,321 A	04-2000	Numao et al.	382/100
*	D	US-6,069,914 A	05-2000	Cox, Ingemar J.	375/150
*	E	US-6,108,434 A	08-2000	Cox et al.	382/100
*	F	US-6,154,571 A	11-2000	Cox et al.	382/250
*	G	US-6,246,775 B1	06-2001	Nakamura et al.	382/100
*	H	US-6,263,087 B1	07-2001	Miller, Matthew L.	382/100
*	I	US-6,278,792 B1	08-2001	Cox et al.	382/100
*	J	US-2001/0016052 A1	08-2001	Miller, Matthew L.	382/100
*	K	US-2001/0033674 A1	10-2001	Chen et al.	382/100
*	L	US-2002/0009208 A1	01-2002	Alattar et al.	382/100
*	M	US-2002/0051560 A1	05-2002	Donescu et al.	382/100

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/760,012	Applicant(s)/Patent Under Reexamination SUGAHARA ET AL.	
	Examiner Max Shikhman	Art Unit 2609	Page 2 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0083324 A1	06-2002	Hirai, Jun	713/176
*	B	US-6,438,252 B1	08-2002	Miller, Matthew L.	382/100
*	C	US-6,449,380 B1	09-2002	Acharya et al.	382/100
*	D	US-2002/0157005 A1	10-2002	Brunk et al.	713/176
*	E	US-2002/0172398 A1	11-2002	Hayashi, Junichi	382/100
*	F	US-6,512,837 B1	01-2003	Ahmed, Farid	382/100
*	G	US-6,546,113 B1	04-2003	Lucas et al.	382/100
*	H	US-2003/0161496 A1	08-2003	HAYASHI et al.	382/100
*	I	US-6,674,876 B1	01-2004	Hannigan et al.	382/100
*	J	US-6,724,911 B1	04-2004	Cox et al.	382/100
*	K	US-6,738,493 B1	05-2004	Cox et al.	382/100
*	L	US-2004/0146180 A1	07-2004	Sugahara et al.	382/100
*	M	US-6,971,010 B1	11-2005	Abdel-Mottaleb, Mohamed	713/176

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/760,012	Applicant(s)/Patent Under Reexamination SUGAHARA ET AL.	
	Examiner Max Shikhman	Art Unit 2609	Page 3 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,990,213 B2	01-2006	Donescu, Ioana	382/100
*	B	US-7,174,030 B2	02-2007	Sugahara et al.	382/100
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.